

## ME2308S-VB Datasheet

## N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
30	0.030 at V <sub>GS</sub> = 10 V	6.5	4.5 nC			
30	0.033 at V <sub>GS</sub> = 4.5 V	6.0	4.5 IIC			

TO-236 (SOT-23)

Top View

3 D

G 1

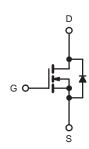
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#### **FEATURES**

- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

DC/DC Converter



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	<b>IGS</b> T <sub>A</sub> = 25 °C,	unless othe	rwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		6.5 <sup>a</sup>		
Continuous Drain Current ( $T_1 = 150 \ ^{\circ}C$ )	T <sub>C</sub> = 70 °C	1-	6.0		
Continuous Drain Current (1) = 150°C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	5.3		
	T <sub>A</sub> = 70 °C		5.0	A	
Pulsed Drain Current		I <sub>DM</sub>	25		
	T <sub>C</sub> = 25 °C		1.4		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.9 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		1.7		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	PD	1.1	w	
	T <sub>A</sub> = 25 °C	U I	1.1 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		0.7 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Temperations)		260			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	90	115	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	60	75	0/11		

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 130 °C/W.



HALOGEN

<b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-					•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μΑ		31		mV/°(
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 - 200 μΛ		- 5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.7	1.1	2.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			1 10	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	10			A
	D(01)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.2 \text{ A}$		0.030		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 2.8 \text{ A}$		0.033		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 4.8 \text{ A}$		11		S
Dynamic <sup>b</sup>	915					
Input Capacitance	C <sub>iss</sub>		[	335		[
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		45		pF
		$v_{\rm DS} = 10^{-10} v, v_{\rm GS} = 0^{-10} v, 1 = 1^{-100112}$		43		
Reverse Transfer Capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.4 A			0.7	
Total Gate Charge	Qg	$v_{\rm DS} = 15$ V, $v_{\rm GS} = 10$ V, $I_{\rm D} = 3.4$ A		4.5 2.1	6.7 3.2	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.4 A		0.85	5.2	
Gate-Drain Charge	Q <sub>gd</sub>	VDS = 10 V, VGS = 4.0 V, ID = 0.4 //		0.65		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.8	4.4	8.8	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		0.0	12	20	52
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 15 V, R <sub>I</sub> = 5.6 Ω		50	75	-
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 13 \text{ V}, \text{ KL} = 3.0 \text{ M}^2$ $I_D \cong 2.7 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		12	20	
Fall Time	t <sub>f</sub>			22	35	
Turn-On Delay Time	-			5	10	ns
Rise Time	t <sub>d(on)</sub> t <sub>r</sub>	V <sub>DD</sub> = 15 V, R <sub>I</sub> = 5.6 Ω		12	20	-
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 10^{\circ}$ , $N_{L} = 3.0^{\circ}$ $I_{D} \simeq 2.7 \text{ A}$ , $V_{GEN} = 10^{\circ}$ V, $R_{g} = 1^{\circ} \Omega$		12	15	
Fall Time	t <sub>f</sub>			5	10	
Drain-Source Body Diode Characteristic				5	10	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		T	1.4	
Pulse Diode Forward Current	I <sub>SM</sub>				15	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2.7 A, V <sub>GS</sub> = 0 V		0.8	1.2	v
Body Diode Reverse Recovery Time	t <sub>rr</sub>	3 7 83 - 1		10	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			5	10	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 2.7 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		6		
Reverse Recovery Rise Time	t <sub>b</sub>			4		ns

Notes:

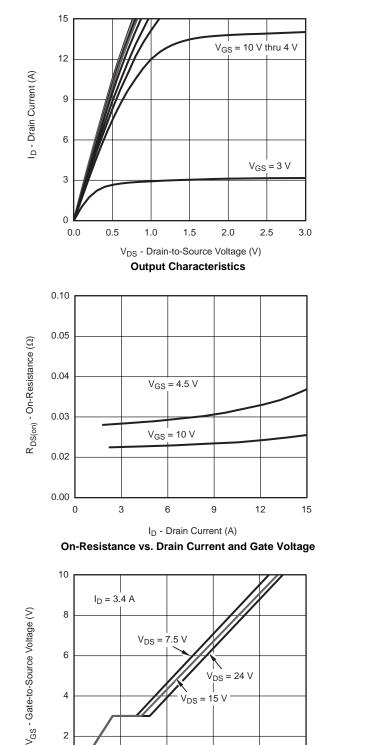
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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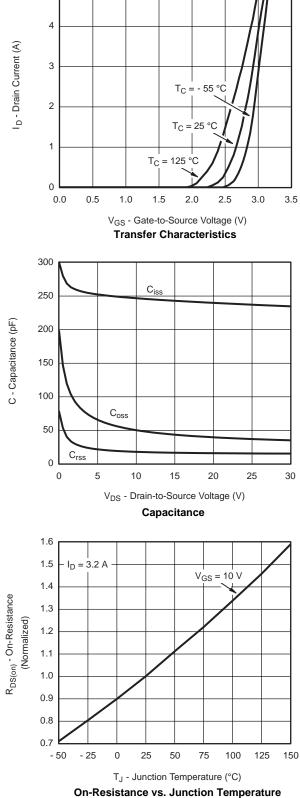


Qg - Total Gate Charge (nC)

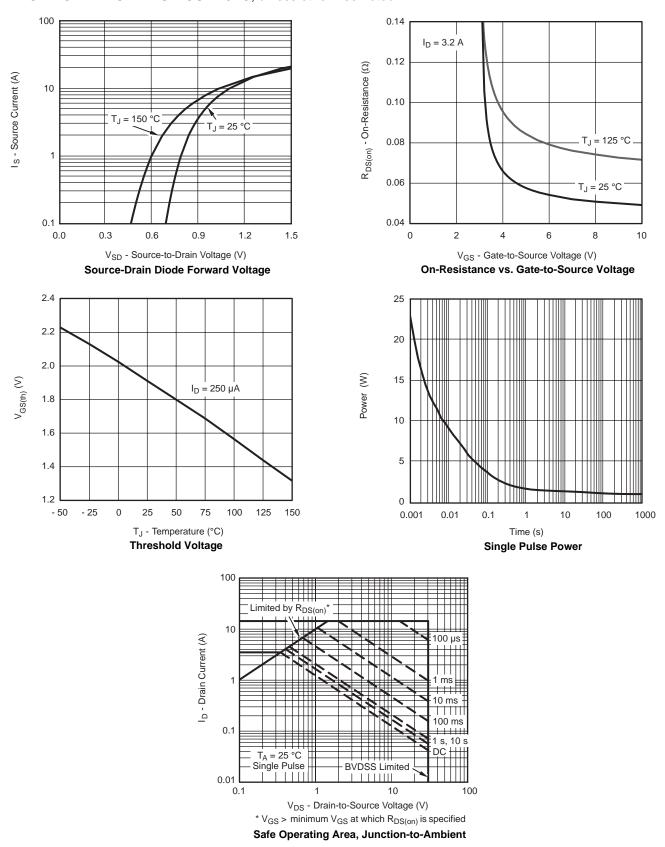
Gate Charge

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

服务热线:400-655-8788

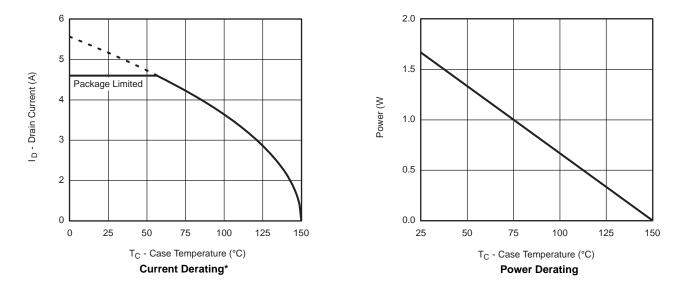






#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

0.1

0.05

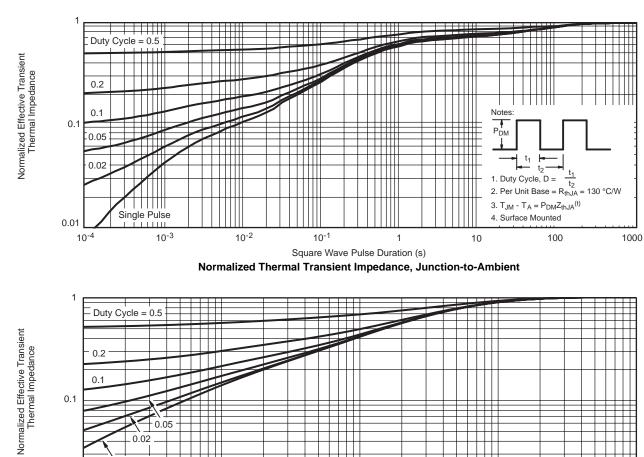
10<sup>-3</sup>

. 0.02 Single Pulse

0.1

0.01 10-4





### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Square Wave Pulse Duration (s) Normalized Thermal Transient Impedance, Junction-to-Foot

10<sup>-2</sup>

10<sup>-1</sup>

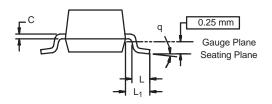
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## SOT-23 (TO-236): 3-LEAD







Dim	MILLIN	<b>METERS</b>	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A <sub>1</sub>	0.01	0.10	0.0004	0.004	
A <sub>2</sub>	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
C	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E <sub>1</sub>	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e <sub>1</sub>	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L <sub>1</sub>	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
ECN: S-03946-Rev. K, 09- DWG: 5479	Jul-01				



#### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)

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